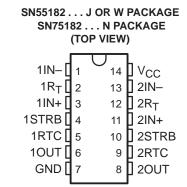
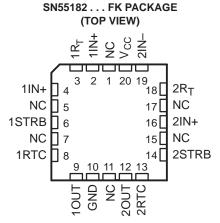
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- Single 5-V Supply
- **Differential Line Operation**
- **Dual Channels**
- **TTL Compatibility**
- ±15-V Common-Mode Input Voltage Range
- ±15-V Differential Input Voltage Range
- **Individual Channel Strobes**
- **Built-In Optional Line-Termination Resistor**
- **Individual Frequency Response Controls**
- **Designed for Use With Dual Differential Drivers SN55183 and SN75183**
- Designed to Be Interchangeable With National Semiconductor DS7820A and **DS8820A**

## description

The SN55182 and SN75182 dual differential line receivers are designed to sense small differential signals in the presence of large common-mode noise. These devices give TTL-compatible output signals as a function of the polarity of the differential input voltage. The frequency response of each channel can be easily controlled by a single external capacitor to provide immunity to differential noise spikes. The output goes to a high level when the inputs are open circuited. A strobe input (STRB) is provided that, when in the low level, disables the receiver and forces the output to a high level.





NC - No internal connection

### THE SN55182 IS NOT RECOMMENDED FOR NEW DESIGNS

The receiver is of monolithic single-chip construction, and both halves of the dual circuits use common power-supply and ground terminals.

The SN55182 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN75182 is characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE**

INPUTS		OUTPUT			
STRB	$v_{ID}$	OUT			
L	Х	Н			
Н	Н	Н			
Н	L	L			

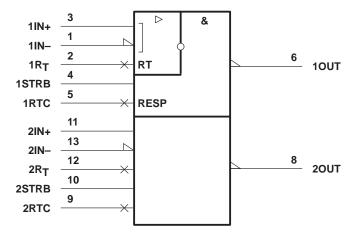
 $H = V_{I} \geq V_{IH} \ min \ or \ V_{ID} \ more$ positive than V<sub>TH</sub> max  $L = V_I \le V_{IL} max or V_{ID} more$ negative than V<sub>TL</sub> max X = irrelevant



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

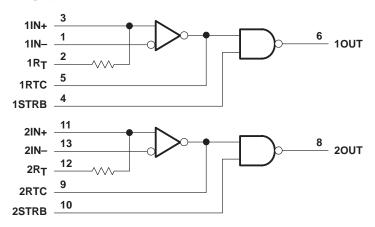


# logic symbol†



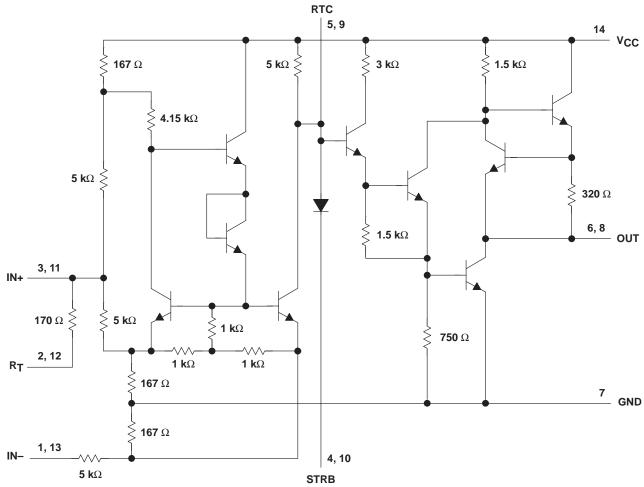
<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the J, N, and W packages.

# logic diagram (positive logic)



Pin numbers shown are for the J, N, and W packages.

# schematic (each receiver)



Resistor values shown are nominal. Pin numbers shown are for the J, N, and W packages.

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	8 V
Common-mode input voltage, V <sub>IC</sub>	±20 V
Differential input voltage, V <sub>ID</sub> (see Note 2)	±20 V
Strobe input voltage, V <sub>I(STRB)</sub>	8 V
Output sink current	
Continuous total power dissipation	See Dissipation Rating Table
Storage temperature range, T <sub>stq</sub>	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: N package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J or W package	ne 300°C
	,0

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential voltages, are with respect to network ground terminal.
  - 2. Differential voltage values are at the noninverting terminal with respect to the inverting terminal.

### **DISSIPATION RATING TABLE**

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
FK <sup>‡</sup>	1375 mW	11.0 mW/°C	880 mW	275 mW
J‡	1375 mW	11.0 mW/°C	880 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	-
W‡	1000 mW	8.0 mW/°C	640 mW	200 mW

<sup>‡</sup> In the FK, J, and W packages, SN55182 chips are alloy mounted.

### recommended operating conditions

	SN55182			SN75182			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	UNII
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.5	5	5.5	V
Common-mode input voltage, V <sub>IC</sub>			±15			±15	V
High-level strobe input voltage, VIH(STRB)	2.1		5.5	2.1		5.5	V
Low-level strobe input voltage, V <sub>IL</sub> (STRB)	0		0.9	0		0.9	V
High-level output current, IOH			-400			-400	μΑ
Low-level output current, I <sub>OL</sub>			16			16	mA
Operating free-air temperature, TA	-55		125	0		70	°C

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# electrical characteristics over recommended ranges of $V_{CC},\ V_{IC},\$ and operating free-air temperature (unless otherwise noted)

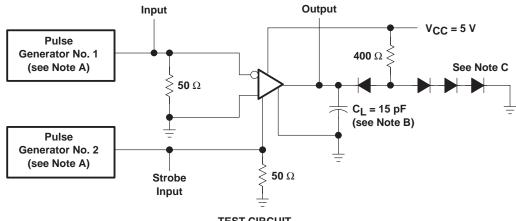
PARAMETER		TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT		
\/ı=.	Positive-going input threshold voltage		$V_0 = 2.5 V$ ,	$V_{IC} = -3 V \text{ to } 3 V$			0.5	V	
V <sub>IT+</sub>	Positive-going inpo	it tillesiloid voltage	I <sub>OH</sub> = -400 μA	$V_{IC} = -15 \text{ V to } 15 \text{ V}$			1	V	
V <sub>IT</sub> Negative-going input threshold v	out throshold voltage	V <sub>O</sub> = 0.4 V,	$V_{IC} = -3 V \text{ to } 3 V$			-0.5	V		
V <sub>IT</sub> _	Negative-going inp	di illieshold voltage	I <sub>OL</sub> = 16 mA	$V_{IC} = -15 \text{ V to } 15 \text{ V}$			-1	V	
I V∩⊔ High-level output voltage F		V <sub>ID</sub> = 1 V, V <sub>(STRB)</sub> = 2.1 V, I <sub>OH</sub> = -400 μA		2.5	4.2	5.5	V		
		V <sub>ID</sub> = -1 V, V <sub>(STRB)</sub> = 0.4 V, I <sub>OH</sub> = -400 μA		2.5	4.2	5.5	v		
VOL	Low-level output ve	oltage	$V_{ID} = -1 V, V_{(STRB)}$	= 2.1 V, I <sub>OL</sub> = 16 mA		0.25	0.4	V	
		Inverting input	V <sub>IC</sub> = 15 V			3	4.2		
	Input current		V <sub>IC</sub> = 0			0	-0.5	mA	
١,,			V <sub>IC</sub> = -15 V			-3	-4.2		
1		Noninverting input	V <sub>IC</sub> = 15 V			5	7		
			V <sub>IC</sub> = 0			-1	-1.4		
			V <sub>IC</sub> = −15 V			-7	-9.8		
I <sub>IH</sub> (STRB)	IH(STRB) High-level strobe input current		V(STRB) = 5.5 V				5	μΑ	
IL(STRB)	Low-level strobe in	put current	V(STRB) = 0			-1	-1.4	mA	
r.	Input resistance	Inverting input			3.6	5		kΩ	
rį		Noninverting input			1.8	2.5			
	Line-terminating resistance		T <sub>A</sub> = 25°C		120	170	250	Ω	
los	Short-circuit outpu	output current $V_{CC} = 5.5 \text{ V},$		VO = 0	-2.8	-4.5	-6.7	mA	
·	Supply current (average per receiver)		V <sub>IC</sub> = 15 V,	V <sub>ID</sub> = -1 V		4.2	6		
Icc			$V_{IC} = 0$ ,	$V_{ID} = -0.5 V$		6.8	10.2	mA	
			$V_{IC} = -15 \text{ V},$	$V_{ID} = -1 V$		9.4	14		

# switching characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

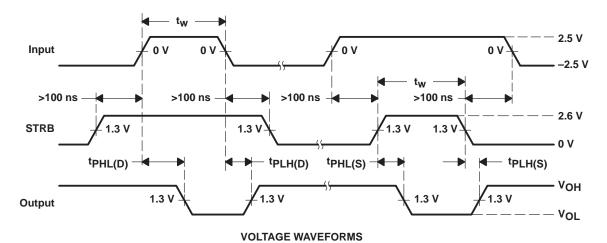
PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
tPLH(D)	Propagation delay time, low- to high-level output from differential input	$R_L = 400 \Omega$ ,	C <sub>L</sub> = 15 pF,	see Figure 1		18	40	ns
t <sub>PHL(D)</sub>	Propagation delay time, high- to low-level output from differential input	$R_L = 400 \Omega$ ,	C <sub>L</sub> = 15 pF,	see Figure 1		31	45	ns
tPLH(S)	Propagation delay time, low- to high-level output from STRB input	$R_L = 400 \Omega$ ,	C <sub>L</sub> = 15 pF,	see Figure 1		9	30	ns
tPHL(S)	Propagation delay time, high- to low-level output from STRB input	$R_L = 400 \Omega$ ,	C <sub>L</sub> = 15 pF,	see Figure 1		15	25	ns

<sup>†</sup> Unless otherwise noted,  $V_{(STRB)} \ge 2.1 \text{ V or open.}$ ‡ All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $V_{IC} = 0$ , and  $T_A = 25^{\circ}C$ .

### PARAMETER MEASUREMENT INFORMATION



**TEST CIRCUIT** 



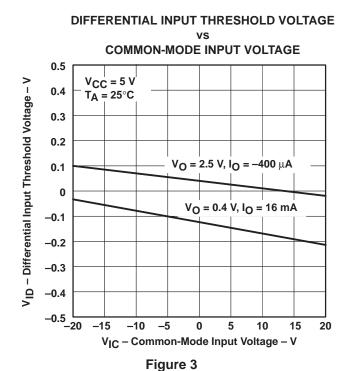
NOTES: A. The pulse generators have the following characteristics:  $Z_O = 50~\Omega$ ,  $t_f \le 10$  ns,  $t_W = 0.5~\pm 0.1~\mu$ s, PRR  $\le 1~MHz$ .

- B. C<sub>L</sub> includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.

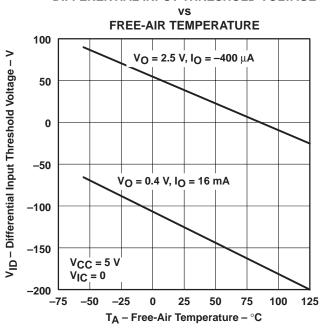
Figure 1. Test Circuit and Voltage Waveforms

### TYPICAL CHARACTERISTICS†

# **DIFFERENTIAL INPUT THRESHOLD VOLTAGE SUPPLY VOLTAGE** 0.3 V<sub>ID</sub> - Differential Input Threshold Voltage - V V<sub>IC</sub> = 0 TA = 25°C 0.2 0.1 $V_{O} = 2.5 \text{ V}, I_{O}^{'} = -400 \mu\text{A}$ 0 $V_0 = 0.4 \text{ V}, I_0 = 16 \text{ mA}$ -0.1 -0.2 -0.34.5 5.5 V<sub>CC</sub> - Supply Voltage - V Figure 2



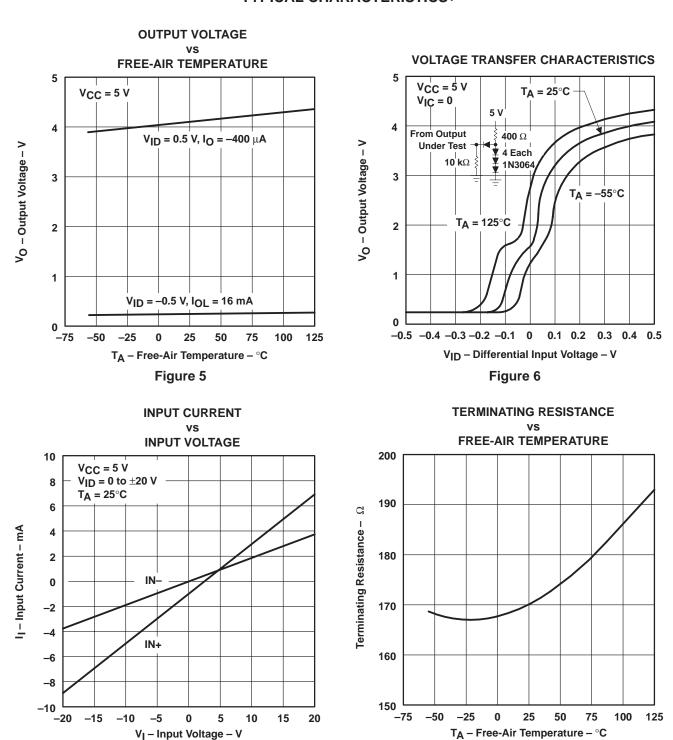
### **DIFFERENTIAL INPUT THRESHOLD VOLTAGE**



<sup>†</sup> Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.

Figure 4



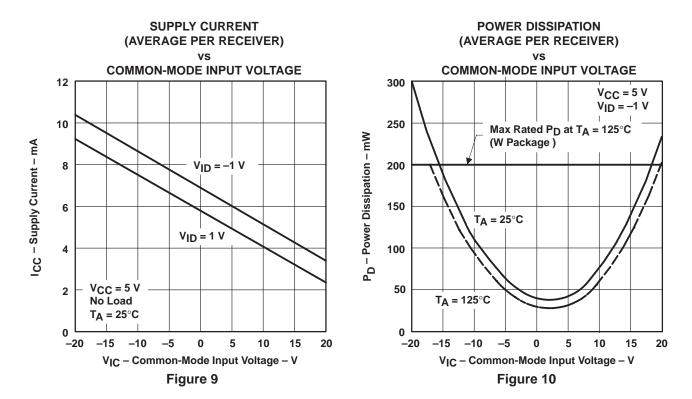


<sup>†</sup> Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.

Figure 8

Figure 7

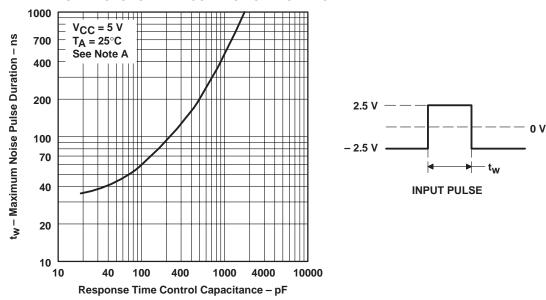




<sup>†</sup> Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.

# MAXIMUM NOISE PULSE DURATION

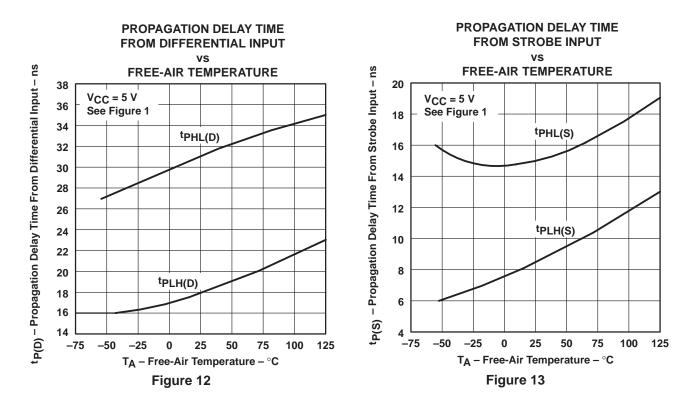
# MAXIMUM RESPONSE TIME-CONTROL CAPACITANCE



NOTE A: Figure 11 shows the maximum duration of the illustrated pulse that can be applied differently without the output changing from the low to high level.

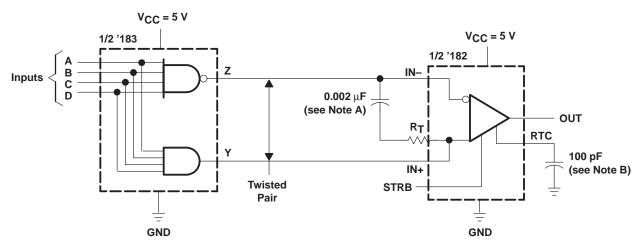
### Figure 11

<sup>†</sup> Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



<sup>†</sup> Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.

### **APPLICATION INFORMATION**



NOTES: A. When the inputs are open circuited, the output is high. A capacitor may be used for dc isolation of the line-terminating resistor. At the frequency of operation, the impedance of the capacitor should be relatively small.

Example: let 
$$\begin{array}{l} f = 5 \text{ MHz} \\ C = 0.002 \ \mu F \\ \\ Z_{(C)} = \frac{1}{2\pi f C} = \frac{1}{2\pi (5 \times 10^6)(0.002 \times 10^{-6})} \\ Z_{(C)} \approx 16 \Omega \end{array}$$

B. Use of a capacitor to control response time is optional.

Figure 14. Transmission of Digital Data Over Twisted-Pair Line

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